

4.4 Maximum Peak Output Power Measurement

4.4.1 Limit

The Maximum Peak Output Power Measurement is 30dBm.

4.4.2 Test Procedure

The maximum peak conducted output power may be measured using a broadband peak RF automatic control unit. The RF automatic control unit shall have a video bandwidth that is greater than or equal to the DTS bandwidth and shall utilize a fast-responding diode detector.

The maximum Average conducted output power may be measured using a wideband RF automatic control unit with a thermocouple detector or equivalent. The RF automatic control unit shall have a video bandwidth that is greater than or equal to the DTS bandwidth and shall utilize a fast-responding diode detector.

4.4.3 Deviation from Standard

No deviation.

4.4.4 Test Setup



RF automatic control unit

EUT

4.4.5 Test Results

Test Rate	Channel	Channel Frequency (MHz)	Maximum Peak Conducted Output Power (dBm)	Limit (dBm)	Result
1M	CH00	2402	-2.79	30.00	Pass
	CH19	2440	-1.42		Pass
	CH39	2480	-0.73		Pass
2M	CH00	2402	-2.64	30.00	Pass
	CH19	2440	-1.31		Pass
	CH39	2480	-0.72		Pass

Note: The test results including the cable loss.

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4.5 Power Spectral Density

4.5.1 Limit

For digitally modulated systems, the power spectral density conducted from the intentional radiator to the antenna shall not be greater than 8dBm in any 3 kHz band during any time interval of continuous transmission.

4.5.2 Test Procedure

Use this procedure when the maximum peak conducted output power in the fundamental emission is used to demonstrate compliance.

Set the RBW =3 kHz.

Set the VBW =10 KHz.

Set the span to 1.5 times the DTS channel bandwidth.

Detector = peak.

Sweep time = auto couple.

Trace mode = max hold.

Allow trace to fully stabilize.

Use the peak marker function to determine the maximum power level.

If measured value exceeds limit, reduce RBW (no less than 3 kHz) and repeat.

The resulting peak PSD level must be 8dBm.

4.5.3 Deviation from Standard

No deviation.

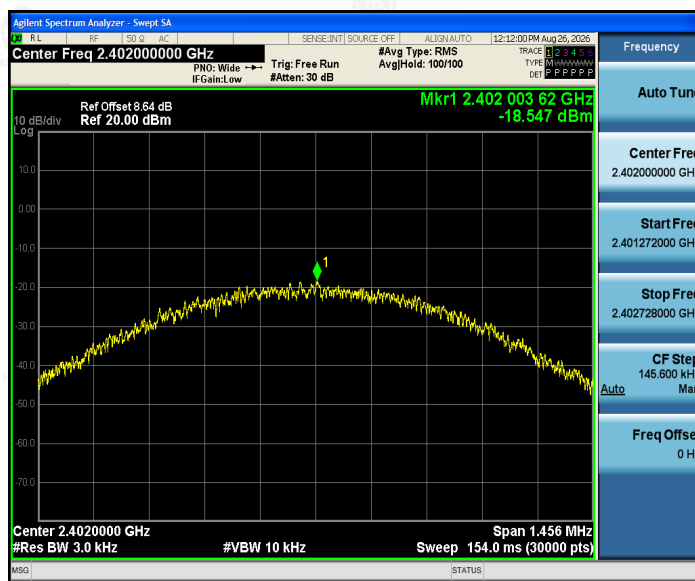
4.5.4 Test Setup



4.5.5 Test Results

Test Rate	Channel	Channel Frequency (MHz)	Result (dBm/3KHz)
1M	CH00	2402	-18.55
	CH19	2440	-16.99
	CH39	2480	-16.33
2M	CH00	2402	-21.82
	CH19	2440	-20.32
	CH39	2480	-19.81
Limit : 8dBm/3KHz			
Test Result		PASS	

1M: CH00



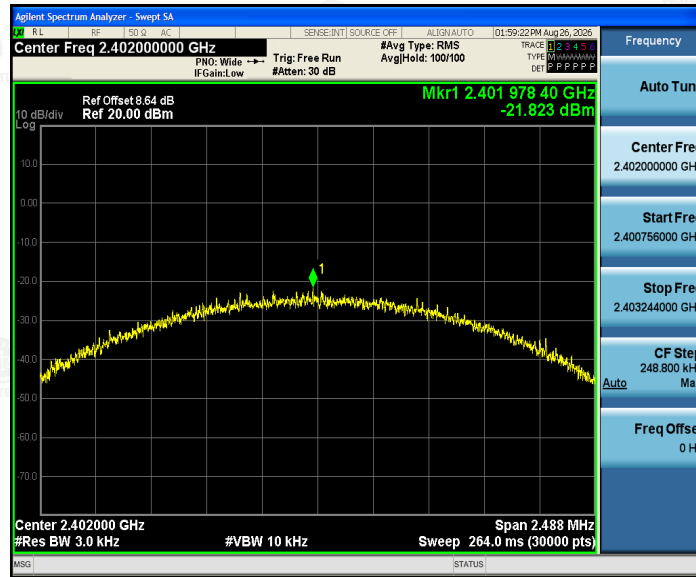
1M: CH19



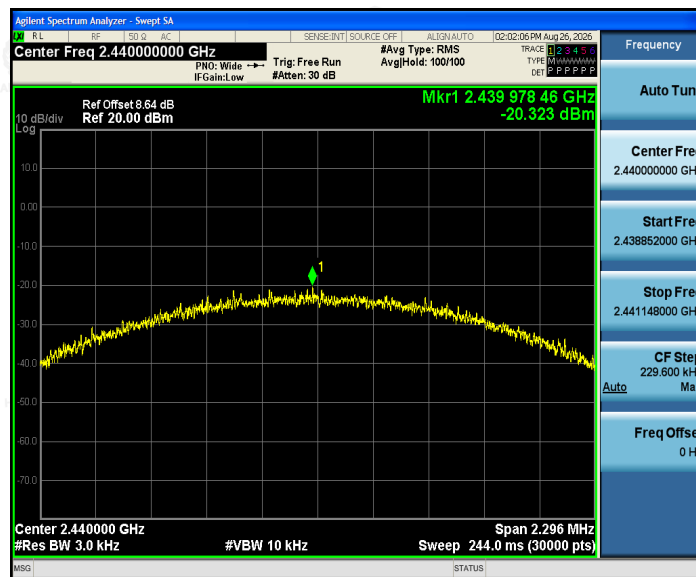
1M: CH39



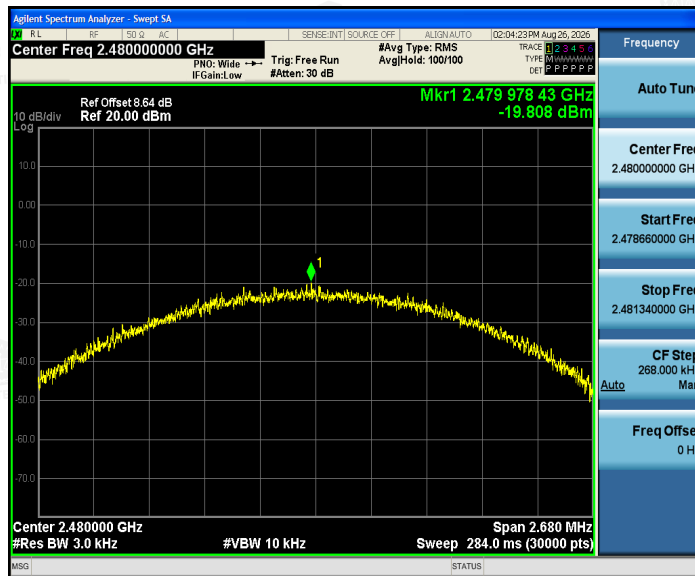
2M: CH00



2M: CH19



2M: CH39



4.6 6dB Bandwidth

4.6.1 Limit

For digital modulation systems, the minimum 6 dB bandwidth shall be at least 500 kHz.

4.6.2 Test Procedure

The transmitter output was connected to the spectrum analyzer through an attenuator. The bandwidth of the fundamental frequency was measured by spectrum analyzer with RBW=100 KHz and VBW=300 KHz.

The 6dB bandwidth is defined as the total spectrum the power of which is higher than peak power minus 6dB.

1. Set RBW = 100 kHz.
2. Set the video bandwidth (VBW) ≥ 3 RBW.
3. Detector = Peak.
4. Trace mode = max hold.
5. Sweep = auto couple.
6. Allow the trace to stabilize.
7. Measure the maximum width of the emission that is constrained by the frequencies associated with the two outermost amplitude points (upper and lower frequencies) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission.

4.6.3 Deviation from Standard

No deviation.

4.6.4 Test Setup



4.6.5 Test Result

Test Rate	Channel	Channel Frequency (MHz)	6dB Bandwidth (MHz)	Limit (KHz)	Result
1M	CH00	2402	0.728	≥ 500	Pass
	CH19	2440	0.724		Pass
	CH39	2480	0.700		Pass
2M	CH00	2402	1.244	≥ 500	Pass
	CH19	2440	1.148		Pass
	CH39	2480	1.340		Pass

1M: CH00



1M: CH19



1M: CH39



2M: CH00



2M: CH19



2M: CH39



4.7 Occupied Bandwidth

4.7.1 Test Procedure

The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission. The following procedure shall be used for measuring 99% power bandwidth:

RBW=1% to 5% of the OBW

VBW=approximately 3 X RBW

Detector=Peak

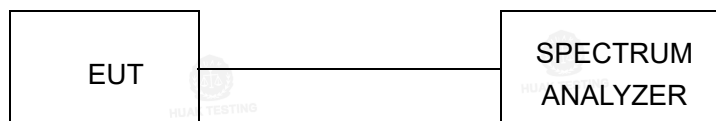
Trace Mode: Max Hold

Use the 99% power bandwidth function of the instrument to measure the Occupied Bandwidth and recorded.

4.7.2 Deviation from Standard

No deviation.

4.7.3 Test Setup



4.7.4 Test Result

N/A

4.8 Band Edge

4.8.1 Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under FCC rules in section 5.8.1, the attenuation required shall be 30 dB instead of 20 dB.

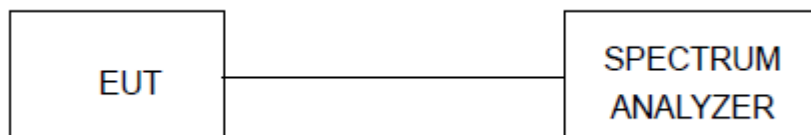
4.8.2 Test Procedure

- The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram below.
- Span = wide enough to capture the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation, RBW $\geq$ 1% of the span, VBW $\geq$ RBW, Sweep = auto, Detector function = peak, Trace = max hold.

4.8.3 Deviation from Standard

No deviation.

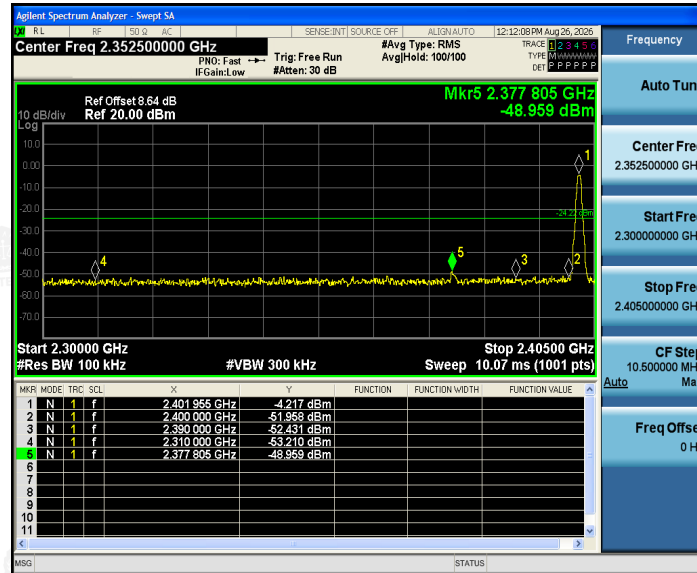
4.8.4 Test Setup



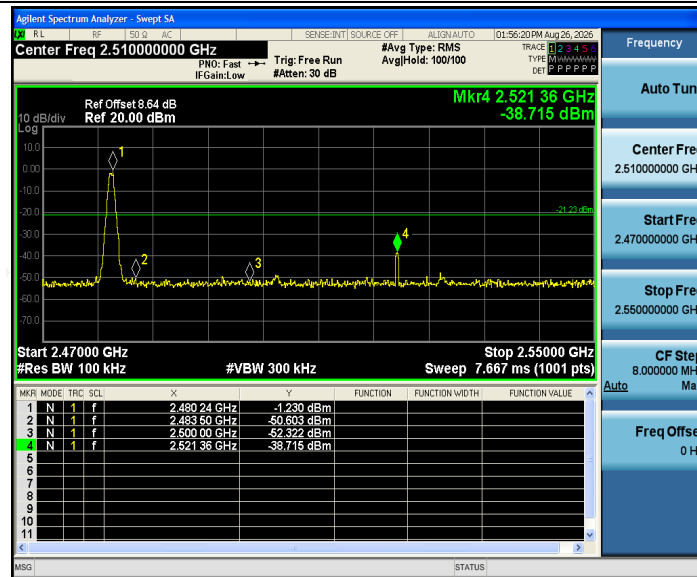
4.8.5 Test Results

PASS

1M:

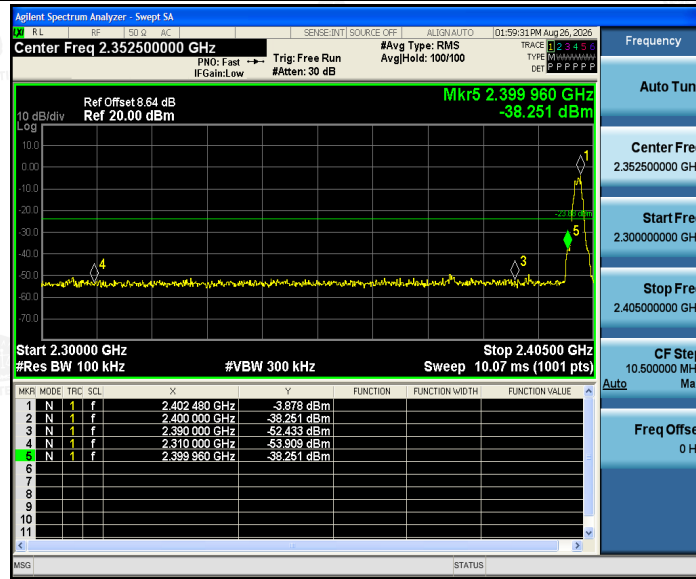


CH00

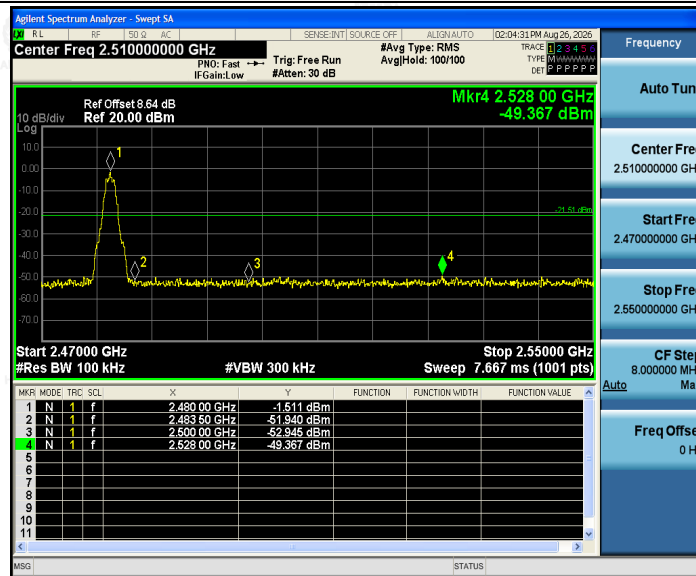


CH39

2M:



CH00



CH39

4.9 Conducted Spurious Emissions

4.9.1 Applied Procedures / Limit

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB.

For below 30MHz, For 9KHz-150kHz, 150K-10MHz, We use the RBW 1KHz, 10KHz, So the limit need to be calculated by $10\lg(BW1/BW2)$. For example For 9KHz-150kHz, RBW 1KHz, The Limit = the highest emission level - $20 - 10\lg(100/1)$ = the highest emission level - 40.

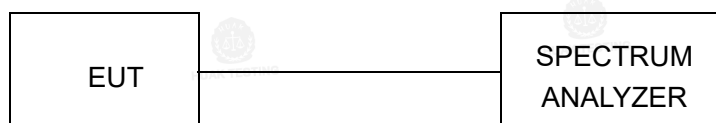
4.9.2 Test Procedure

- The EUT was directly connected to the spectrum analyzer and antenna output port as shown in the block diagram below.
- Span = wide enough to capture the peak level of the emission operating on the channel closest to the band edge, as well as any modulation products which fall outside of the authorized band of operation, $RBW \geq 1\%$ of the span, $VBW \geq RBW$, Sweep = auto, Detector function = peak, Trace = max hold.

4.9.3 Deviation from Standard

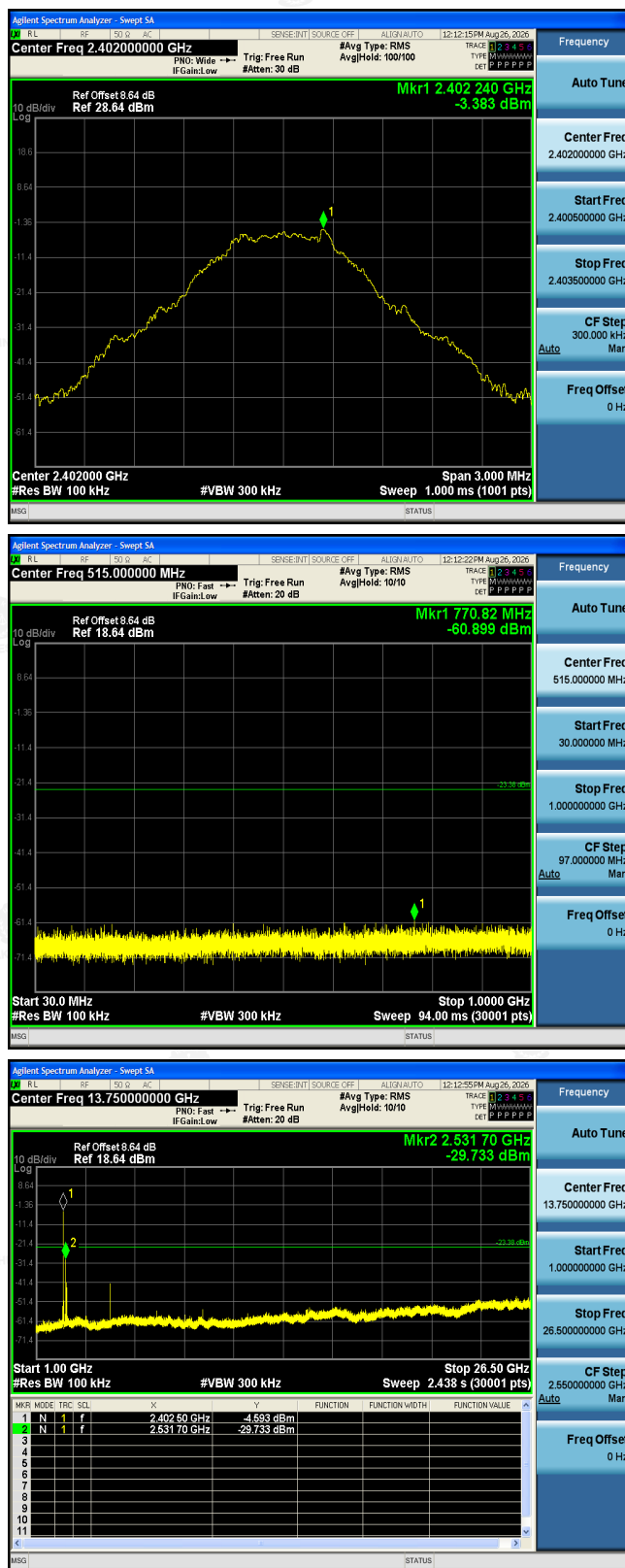
No deviation.

4.9.4 Test Setup



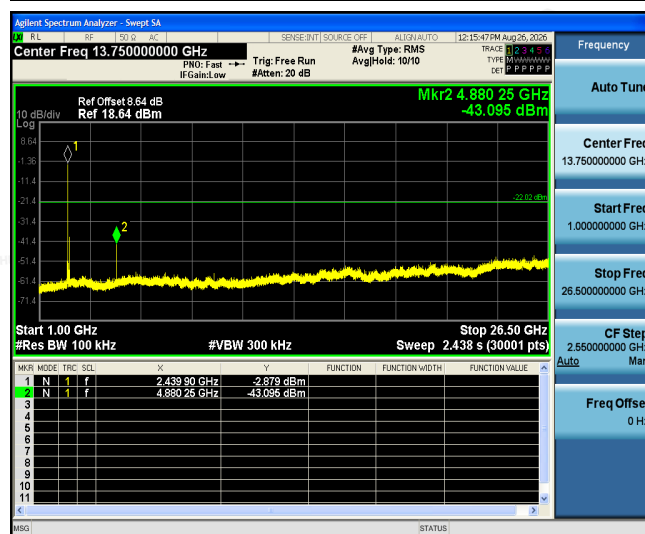
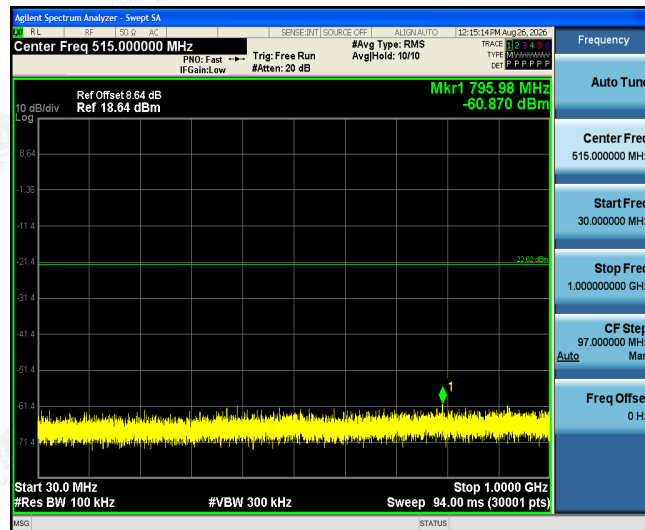
4.9.5 Test Results

1M: CH00



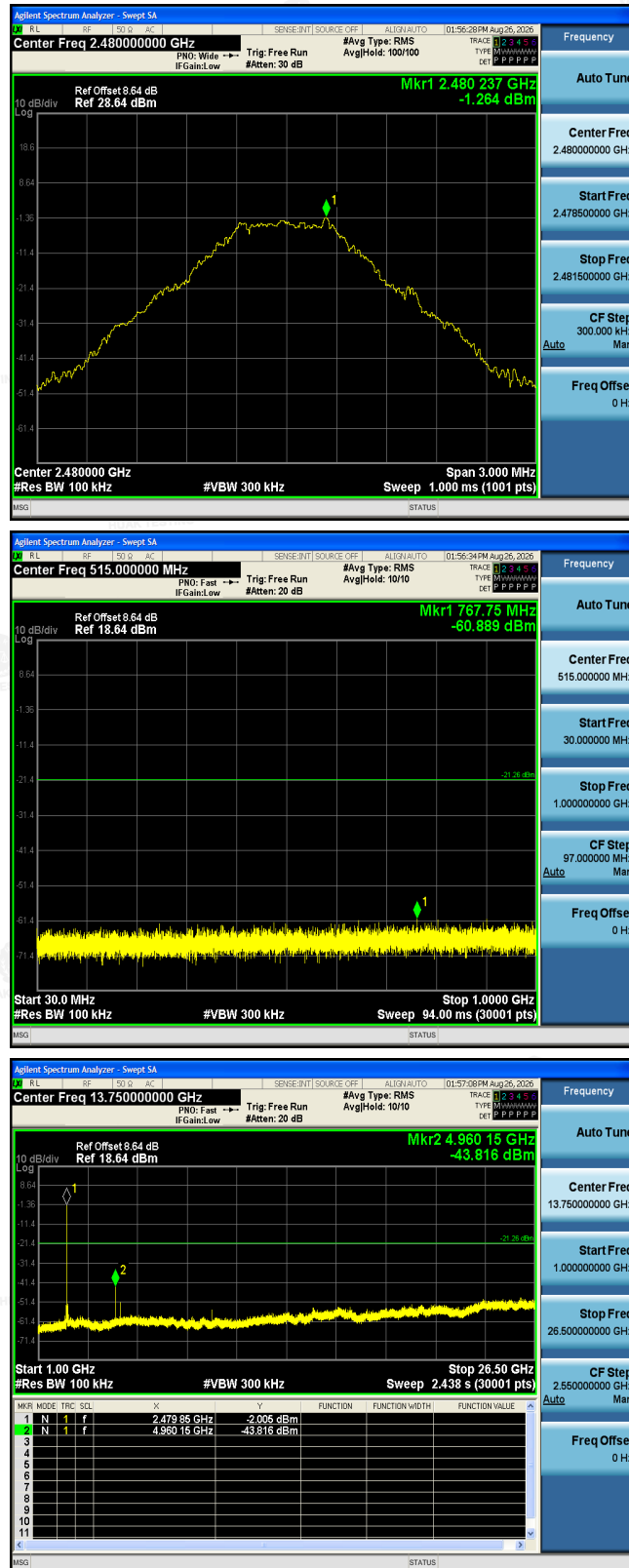
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1M: CH19



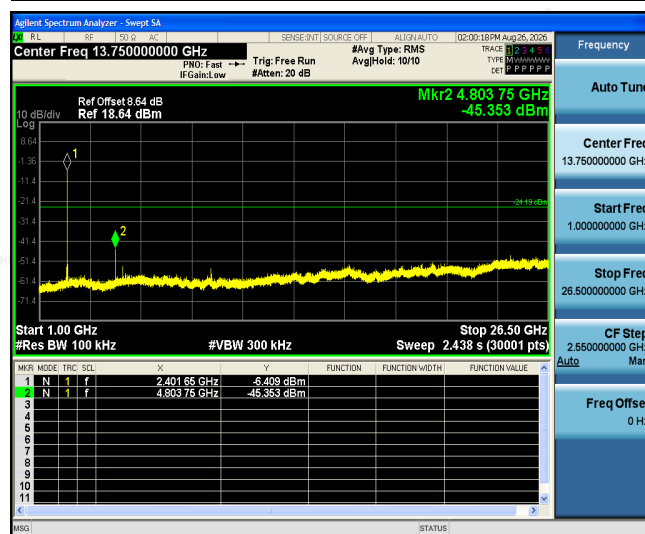
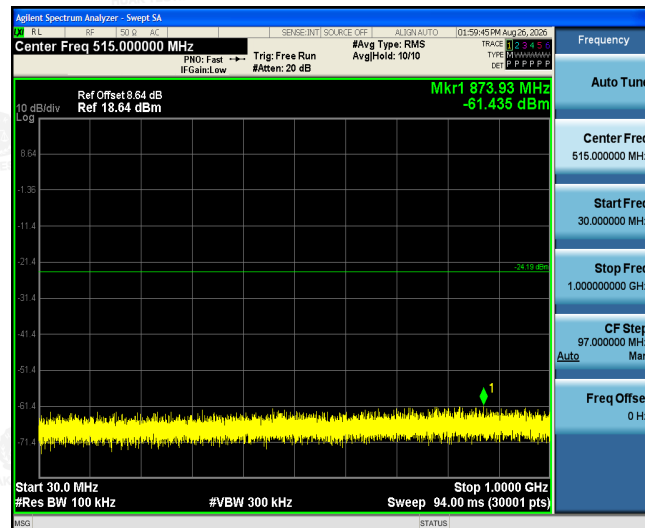
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1M: CH39



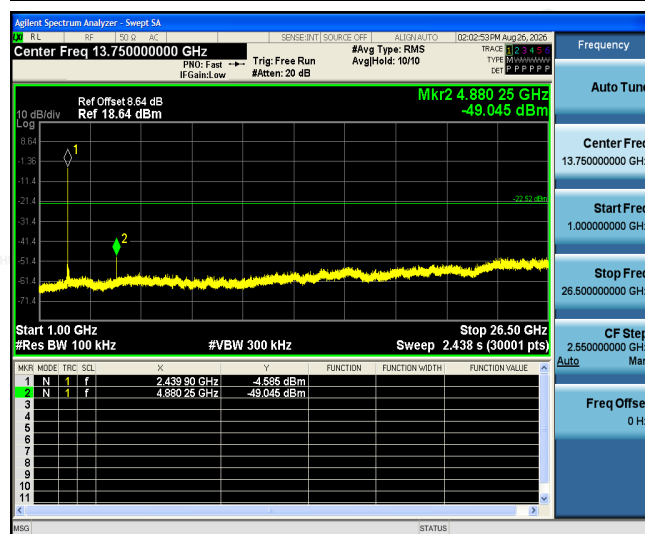
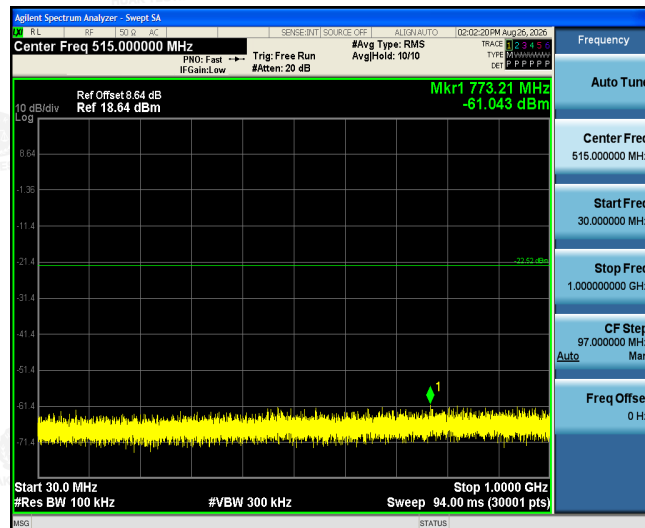
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2M: CH00



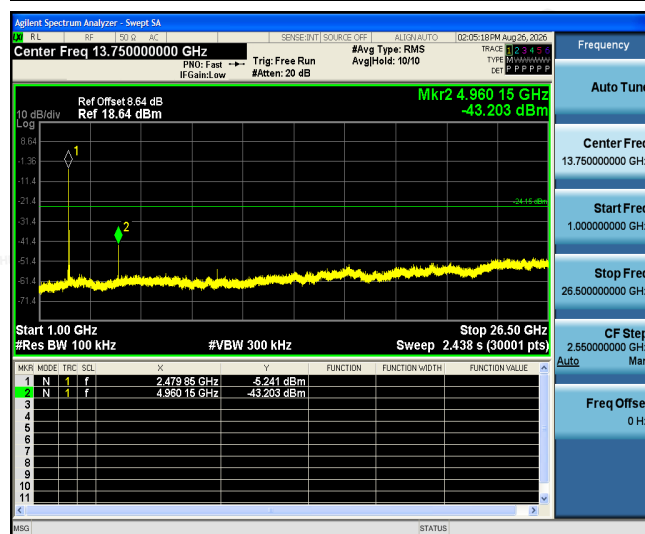
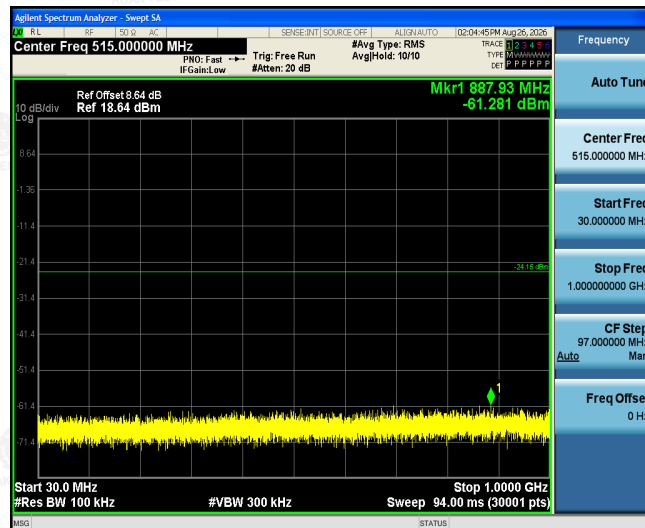
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2M: CH19



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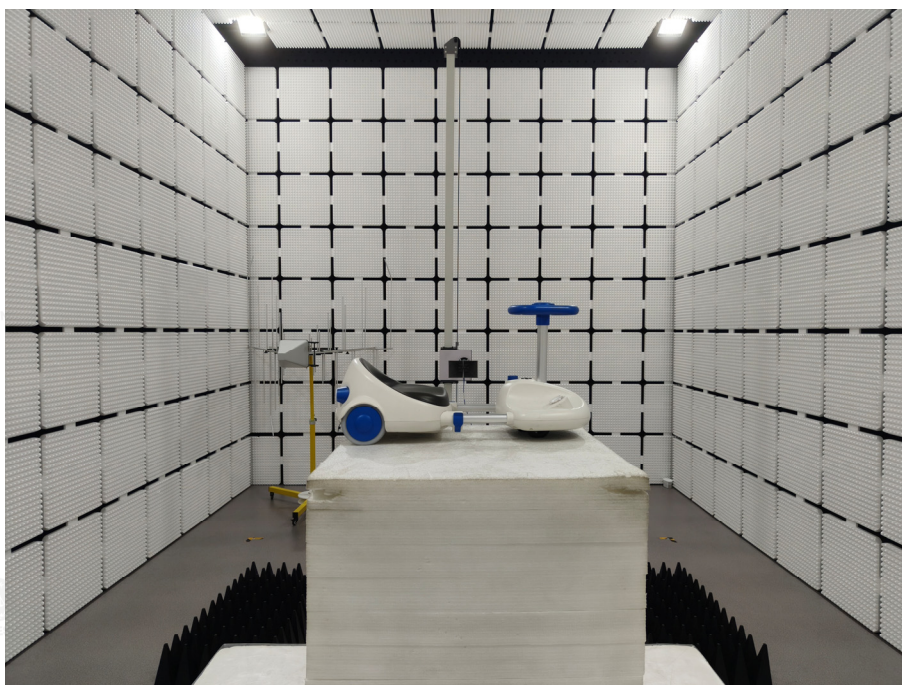
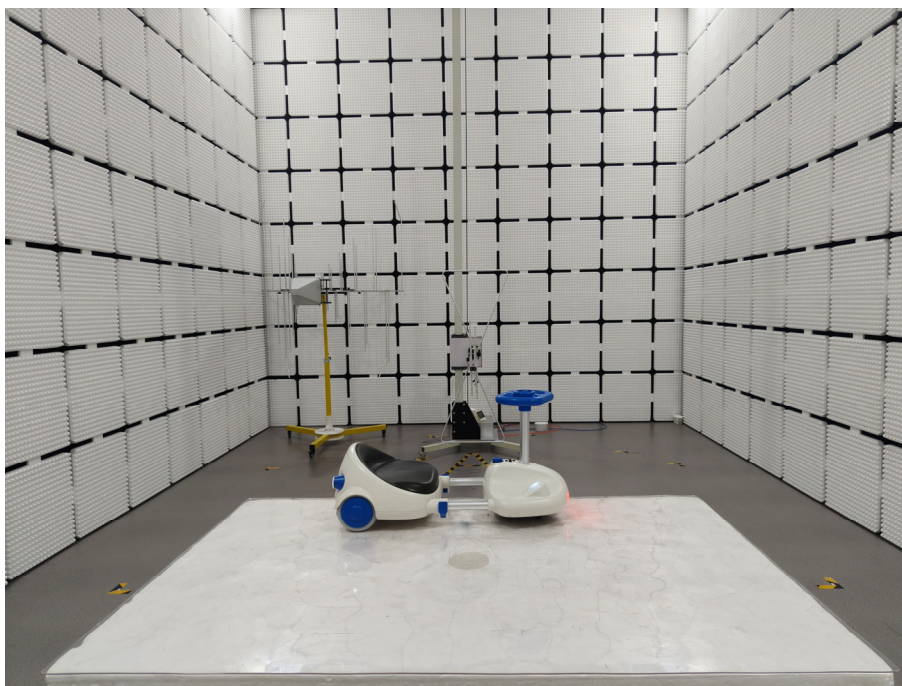
2M: CH39



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5 Test Setup Photos of the EUT

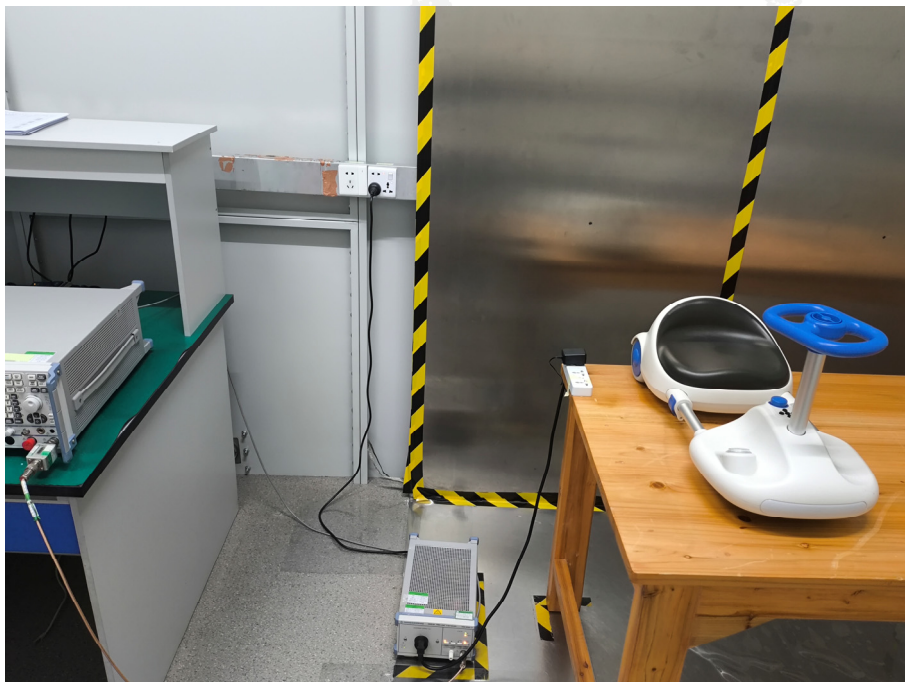
Radiated Emission



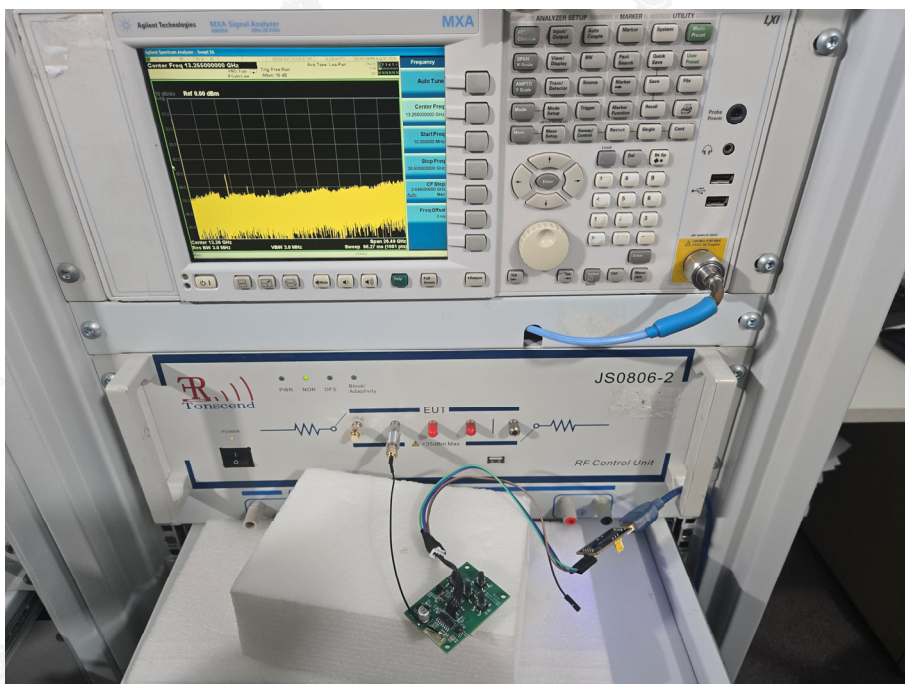
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AC Conducted Emission



RF Conducted Emission



6 Photos of the EUT

Reference to the report: ANNEX A of external photos and ANNEX B of internal photos.

-----End of test report-----